

<b>Notice of References Cited</b>	Application/Control No. 09/750,423	Applicant(s)/Patent Under Reexamination RICK, RALF	
	Examiner Shin-Hon Chen	Art Unit 2131	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,023,763	02-2000	Grumstrup et al.	713/200
	B	US-4,924,378	05-1990	Hershey et al.	713/201
	C	US-2001/0011254	08-2001	CLARK, JONATHAN	705/59
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06051975 A	02-1994	Japan	OKUBO, KENJI	G06F 09/06
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.